

### **IGBT** Module

### **SK30MLI066**

**Target Data** 

#### **Features**

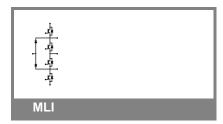
- Compact design
- · One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- Trench IGBT technology
- CAL technology FWD

## **Typical Applications\***

- 3 Level Inverter
- UPS

#### Remarks

- Visol = 3000V AC, 1s, 50Hz
- Dynamic measure: DUT= IGBT (Gate pin 1) and Neutral Clamp Diode (Kathode pin 16) as free-wheeling diode



<b>Absolute Maximum Ratings</b> $T_s = 25  ^{\circ}\text{C}$ , unless otherwise specified						
Symbol	Conditions			Values	Units	
IGBT					·	
$V_{CES}$	$T_j = 25 ^{\circ}\text{C}$ $T_i = 175 ^{\circ}\text{C}$			600	V	
I <sub>C</sub>	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 25 °C		40	Α	
		T <sub>s</sub> = 70 °C		31	Α	
I <sub>CRM</sub>	I <sub>CRM</sub> = 2 x I <sub>Cnom</sub>			60	Α	
$V_{GES}$				± 20	V	
t <sub>psc</sub>	$V_{CC}$ = 360 V; $V_{GE} \le 20$ V; $V_{CES} < 600$ V	T <sub>j</sub> = 150 °C		6	μs	
Inverse l	Diode				•	
I <sub>F</sub>	T <sub>j</sub> = 175 °C	$T_s = 25 ^{\circ}C$		37	Α	
		T <sub>s</sub> = 70 °C		30	Α	
I <sub>FRM</sub>	I <sub>FRM</sub> = 2 x I <sub>Fnom</sub>			60	Α	
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; half sine wave	T <sub>j</sub> = 150 °C		160	Α	
Freewhe	eling Diode				•	
I <sub>F</sub>	T <sub>j</sub> = 175 °C	$T_s$ = 25 °C		36	Α	
		$T_s = 70  ^{\circ}C$		28	Α	
I <sub>FRM</sub>	I <sub>FRM</sub> = 2 x I <sub>Fnom</sub>			60	Α	
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; half sine wave	T <sub>j</sub> = 150 °C		160	Α	
Module	•				•	
I <sub>t(RMS)</sub>					Α	
T <sub>vj</sub>				-40 +175	°C	
T <sub>stg</sub>				-40 +125	°C	
V <sub>isol</sub>	AC, 1 min.			2500	V	

<b>Characteristics</b> T <sub>s</sub> = 25 °C, unless otherwise specifi						ecified
Symbol	Conditions		min.	typ.	max.	Units
IGBT						
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_{C} = 0.43$ mA		5	5,8	6,5	V
I <sub>CES</sub>	$V_{GE} = 0 V, V_{CE} = V_{CES}$	T <sub>j</sub> = 25 °C			0,0016	mA
I <sub>GES</sub>	V <sub>CE</sub> = 0 V, V <sub>GE</sub> = 20 V	T <sub>j</sub> = 25 °C			300	nA
V <sub>CE0</sub>		T <sub>j</sub> = 25 °C		0,9	1,1	V
		T <sub>j</sub> = 150 °C		0,8	1	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V	T <sub>i</sub> = 25°C		18	28	mΩ
		T <sub>j</sub> = 150°C		27	38	$m\Omega$
V <sub>CE(sat)</sub>	I <sub>Cnom</sub> = 30 A, V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C <sub>chiplev.</sub>		1,45		V
		$T_j = 150^{\circ}C_{chiplev.}$		1,65		V
C <sub>ies</sub>				1,63		nF
C <sub>oes</sub>	$V_{CE} = 25, V_{GE} = 0 V$	f = 1 MHz		0,18		nF
C <sub>res</sub>				0,05		nF
$Q_G$	V <sub>GE</sub> =-7V+15V			275		nC
t <sub>d(on)</sub>				24		ns
t <sub>r</sub>	$R_{Gon} = 25 \Omega$	V <sub>CC</sub> = 300V		27		ns
E <sub>on</sub>	di/dt = 2335 A/µs	I <sub>C</sub> = 30A		0,97		mJ
$t_{d(off)}$	$R_{Goff} = 25 \Omega$	T <sub>j</sub> = 150 °C		328		ns
t <sub>f</sub>	di/dt = 2335 A/µs	V <sub>GE</sub> = -7/+15 V		54		ns
E <sub>off</sub>				1,77		mJ
$R_{th(j-s)}$	per IGBT			1,65		K/W



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Characteristics								
Symbol	Conditions		min.	typ.	max.	Units		
Inverse Diode (Antiparallel Diode)								
$V_F = V_{EC}$	$I_{Fnom} = 30 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25  ^{\circ}C_{chiplev.}$		1,5		V		
		$T_j = 150  ^{\circ}C_{chiplev.}$		1,5		V		
$V_{F0}$		T <sub>j</sub> = 25 °C		1		V		
		T <sub>j</sub> = 150 °C		0,9		V		
r <sub>F</sub>		T <sub>j</sub> = 25 °C		16,7	20	mΩ		
		T <sub>j</sub> = 150 °C		20	23,3	$m\Omega$		
I <sub>RRM</sub>	I <sub>F</sub> = 30 A	T <sub>j</sub> = 150 °C		30		Α		
$Q_{rr}$	di/dt = 2335 A/µs			1,6		μC		
E <sub>rr</sub>	V <sub>R</sub> = 300V			0,26		mJ		
$R_{th(j-s)D}$	per diode			2,3		K/W		
Freewhee	ling Diode (Neutral (							
$V_F = V_{EC}$	$I_{Fnom} = 30 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25  ^{\circ}C_{\text{chiplev.}}$		1,5		V		
		T <sub>j</sub> = 150 °C <sub>chiplev.</sub>		1,5		V		
$V_{F0}$		T <sub>j</sub> = 25 °C		1		V		
		T <sub>j</sub> = 150 °C		0,9		V		
r <sub>F</sub>		T <sub>j</sub> = 25 °C		16,7	20	V		
		T <sub>j</sub> = 150 °C		20	23,3	V		
I <sub>RRM</sub>	I <sub>F</sub> = 30 A	T <sub>j</sub> = 150 °C				Α		
$Q_{rr}$	di/dt = -950 A/μs					μC		
E <sub>rr</sub>	V <sub>R</sub> =300V			0,26		mJ		
$R_{\text{th(j-s)FD}}$	per diode			2,3		K/W		
M <sub>s</sub>	to heat sink		2,25		2,5	Nm		
w				30		g		

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.



